

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/718,430	JU ET AL.		
Examiner	Art Unit		
A. J. HEINZ	2627		

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East	12/7/06	174
See Search		
Strategy		
Consulted:		

Wednesday, December 06, 2006 9:28 PM
Cao, Allen; Castro, Angel; Chen, Tianjie; Evans, Jefferson;
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